

600 V / 4 A, High-Side Automotive Gate Driver IC

FAD7171MX

Description

The FAD7171MX is a monolithic high–side gate drive IC that can drive high–speed MOSFETs and IGBTs that operate up to +600 V. It has a buffered output stage with all NMOS transistors designed for high pulse current driving capability and minimum cross–conduction. **onsemi**'s high–voltage process and common–mode noise–canceling techniques provide stable operation of the high–side driver under high dv/dt noise circumstances. An advanced level–shift circuit offers °C

MARKING DIAGRAM

FAD7171MX

SOIC8 (Pb-Free / Halogen Free) 2500 / Tape & Reel

Applications

- Common Rail Injection Systems
- DC-DC Converter
- Motor Drive (Electric Power Steering, Fans)

Related Product Resources

- FAN7171 Product Folder
- FAD7171 Product Folder
- AND9674 Design and Application Guide of Bootstrap Circuit for High-Voltage Gate-Drive IC
- <u>AN-8102</u> Recommendations to Avoid Short Pulse Width Issues in HVIC Gate Driver Applications
- AN-9052 Design Guide for Selection of Bootstrap Components

PIN DESCRIPTION

Pin No.	Symbol	Description	
1	V_{DD}	Supply Voltage	
2	IN	Logic Input for High-Side Gate Driver Output	
3	NC	No Connection	
4	GND	Ground	
5	NC	No Connection	
6	Vs	High-Voltage Floating Supply Return	
7	НО	High-Side Driver Output	
8	V _B	High-Side Floating Supply	

ABSOLUTE MAXIMUM RATINGS

Symbol	Characteristics	Min	Max	Unit
Vs	High-Side Floating Offset Voltage	V _B – 25	V _B + 0.3	V
V _B	High-Side Floating Supply Voltage	-0.3	625.0	V
V_{HO}	High-Side Floating Output Voltage	V _S - 0.3	V _B + 0.3	V
V_{DD}	Low-Side and Logic Supply Voltage	-0.3	25	V
V_{IN}	Logic Input Voltage	-0.3	V _{DD} + 0.3	V
dV _S /dt	Allowable Offset Voltage Slew Rate	-	±50	V/ns
P_{D}	Power Dissipation (Notes 2, 3, 4)	-	0.625	W
θ_{JA}	Thermal Resistance	_	200	°C/W
TJ	Junction Temperature	•		

ELECTRICAL CHARACTERISTICS $(V_{BIAS} (V_{DD}, V_{BS}) = 15 \text{ V}, -40^{\circ}\text{C} \le T_{A} \le 125^{\circ}\text{C}$, unless otherwise specified. The V_{IN} and I_{IN} parameters are referenced to GND. The V_{O} and I_{O} parameters are relative to V_{S} and are applicable to the respective output HO)
Symbol
- Cymbol - C

TYPICAL PERFORMANCE CHARACTERISTICS

tOFF (ns)

t_F (ns)

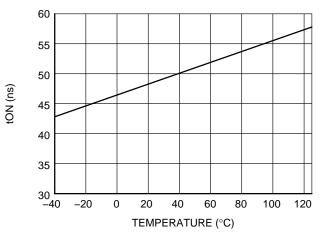


Figure 4. Turn-On Propagation Delay vs.
Temperature

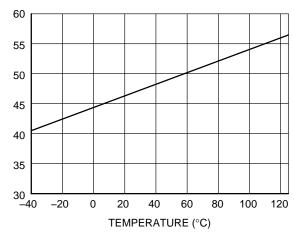


Figure 5. Turn-Off Propagation Delay vs.
Temperature

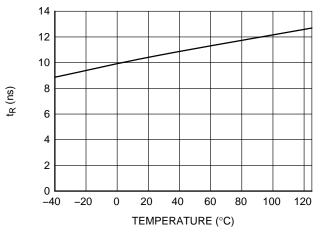


Figure 6. Turn-On Rise Time vs. Temperature

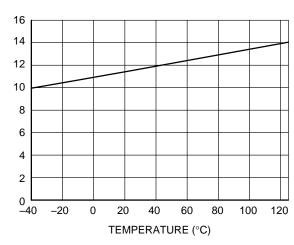


Figure 7. Turn-Off Fall Time vs. Temperature

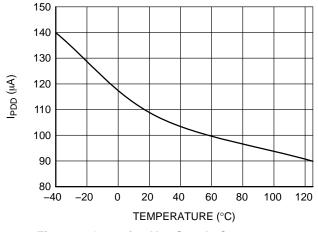


Figure 8. Operating V_{DD} Supply Current vs. Temperature

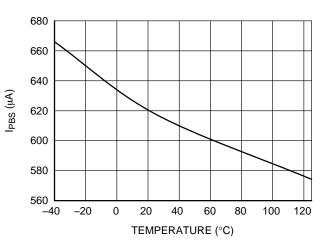


Figure 9. Operating V_{BS} Supply Current vs. Temperature

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

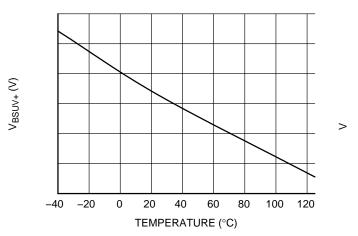


Figure 10. V_{BS} UVLO+ vs. Temperature

-40 -20 0 20 40 60 80 100 120 TEMPERATURE (°C)

Figure 11. V_{BS} UVLO- vs. Temperature

-40 -20 0 20 40 60 80 100 120 TEMPERATURE (°C)

Figure 12. Logic High Input Voltage vs. Temperature

-40 -20 0 20 40 60 80 100 120 TEMPERATURE (°C)

Figure 13. Logic Low Input Voltage vs. Temperature

-40 -20 0 20 40 60 80 100 120 TEMPERATURE (°C)

Figure 14. RIN vs. Temperature

-40 -20 0 20 40 60 80 100 120 TEMPERATURE (°C)

Figure 15. Output Voltage vs. Temperature

SWITCHING TIME DEFINITIONS

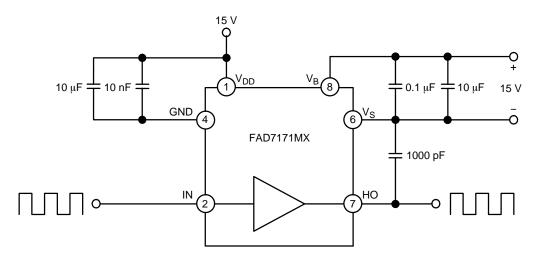


Figure 22. Switching Time Test Circuit (Referenced 8-SOIC)

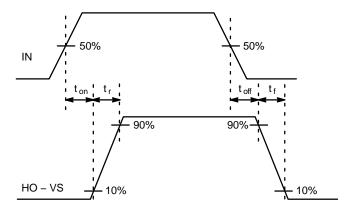


Figure 23. Switching Time Waveform Definitions

